

Recovery Of Clock and Data Using Quadrature Clock Signals

BACKGROUND OF THE PRESENT INVENTION

[0001] In an asynchronous serial data link, there is no common clock connection between the device sending the data and the device receiving that data. The receiving device must extract (or recover) a clock from the transitions in the received data stream. Typically a phase-locked loop (PLL) is used to phase-lock to the received data and control the frequency of a new, local clock (the "recovered clock"). The recovered clock is then used to sample and re-time ("recover") the received data.

[0002] Fig. 1A is a block diagram depicting a known clock and data recovery (CDR) circuit 100 according to the Background Art, corresponding to published U.S. Patent Application, Publication No. 2002/0021470. CDR circuit 100 includes: a half-rate phase detector 102; a charge pump 104; a low pass filter (LPF) 106; and a half-rate voltage-controlled oscillator (VCO) 108. Phase-detector 102 produces a signal that is proportional to the phase difference between the received data (D_{in}) and a locally re-created clock (CK). The clock has a rate that is half of the rate of received data D_{in} , hence phase detector 102 is described as a half-rate phase detector. Where D_{in} has a rate of 10 Gb/sec, the rate of re-created clock CK is 5 GHz.

[0003] Charge pump 104 discharges or charges according to the output of phase-detector 102. VCO 108 receives a filtered (via LPF 106) output of charge pump 104, which represents a fine control input, and a relatively coarse control input, and re-creates the clock (CK).

[0004] Phase detector 102 also outputs two recovered data signals (D_A and D_B), each of which has a rate of 5 Gb/sec. Together, D_A and D_B represent a recovered and re-timed version of received data D_{in} .

[0005] Fig. 1B is a more detailed block diagram of phase detector 102 according to the Background Art, which includes: a pair of data latches 122 and 124, a corresponding exclusive-OR (XOR) gate 126; another pair of data latches 128 and 130, and their corresponding XOR gate 132. It is noted that non-inverted signals in Fig. 1B have an inverted counterpart; for simplicity of illustration, however, the inverted counterparts have not been labeled, e.g., Fig. 1B does not show the labels $\overline{D_{in}}$, $\overline{X_1}$, etc.

[0006] Outputs X1 and X2 of latches 122 and 124 are combined by XOR gate 126 to produce the phase difference signal (labeled "ERROR" in Fig. 1B). Similarly, XOR 132 combines outputs Y1 and Y2 of latches 128 and 130, respectively. It is noted that, in contrast to signal ERROR, the output of XOR 132 does not vary in pulse width, hence it is given the label "REFERENCE."

SUMMARY

[0007] An embodiment of the present invention provides a quarter-rate phase detector. Such a phase detector may include: four latches controllable to latch, at different times according to quadrature clock signals, respectively, data received by the phase detector so as to form latched signals; and error circuit to combine corresponding ones of the latched signals, respectively, the error circuit providing a plurality of intermediate signals; and a multiplexing

unit to selectively output the intermediate signals as a phase error signal. A related method can have similar features.

[0008] Additional features and advantages of the present invention will be more fully apparent from the following detailed description of example embodiments, the accompanying drawings and associated claims.

BRIEF DESCRIPTION OF THE DRAWINGS

[0009] Fig. 1A is a block diagram depicting a known clock and data recovery (CDR) circuit 100 according to the Background Art.

[0010] Fig. 1B is a more detailed block diagram of the phase detector of Fig. 1A.

[0011] Fig. 2 is a block diagram depicting a clock and data recovery (CDR) circuit according to an embodiment of the present invention.

[0012] Fig. 3A is a block diagram depicting a quarter-rate phase detector according to an embodiment of the present invention.

[0013] Fig. 3B is a table depicting an example truth table for a multiplexer according to an embodiment of the present invention.

[0014] Fig. 3C depicts waveforms I and Q as they change to exhibit the combinations listed in the table of Fig. 3B.

[0015] Fig. 3D is a block diagram depicting a multiplexer, according to an embodiment of the present invention, whose operation corresponds to the table of Fig. 3B.

[0016] Figs. 4, 5 and 6 each depict waveforms for signals mentioned Fig. 3A, for different example circumstances, respectively.

[0017] The accompanying drawings are intended to depict example embodiments of the present invention and should not be interpreted to limit the scope thereof.

DETAILED DESCRIPTION OF PREFERRED EMBODIMENTS

[0018] Hereinafter, embodiments of the present invention will be described in detail with reference to the attached drawings. However, the embodiments of the present invention may be modified into various other forms, and the scope of the present invention must not be interpreted as being restricted to the embodiments. The embodiments are provided to more completely explain the present invention to those skilled in the art. The drawings are not to scale and so may exhibit exaggerations for clarity. Like numbers refer to like elements throughout.

[0019] Fig. 2 is a block diagram depicting a clock and data recovery (CDR) circuit 200 according to an embodiment of the present invention. CDR circuit 200 is a phase-locked loop. CDR 200 includes: a quarter-rate phase detector 210 (according to another embodiment of the present invention) that operates upon the received data (D_{in}); a charge pump 220; a low pass filter (LPF) 230; and a quadrature voltage-controlled oscillator (VCO) 240.

[0020] Phase-detector 210 produces: an error signal (E) and its corresponding inverse signal (Eb) whose pulse widths are proportional to the difference in phase between latched versions of the received data (D_{in}) and a locally regenerated clock (reGen_CK) and its corresponding inverse ($\overline{\text{reGen_CK}}$), respectively; and a reference signal (R) and its corresponding inverse signal (Rb)

whose pulse widths are not proportional to the difference in phase between twice latched versions of received data D_{in} and a locally regenerated clocks $reGen_CK$ and $\overline{reGen_CK}$, respectively. Signals R and Rb have pulse widths that are substantially constant. Charge pump 220 discharges or charges according to the difference in pulse widths of the outputs of phase-detector 210, e.g., E and R . VCO 240 receives a filtered (via LPF 230) output of charge pump 220 and produces clocks $reGen_CK$ and $\overline{reGen_CK}$.

[0021] Clock $reGen_CK$ has two signals, I and Q . Similarly, clock $\overline{reGen_CK}$ has the corresponding inverse signals, Ib and Qb . The use of labels I , Ib , Q and Qb is explained as follows. Signals Q/Qb exhibit a phase lag of 90° relative to signals I/Ib , respectively, and are described as being (relatively) in quadrature; hence, labels Q and Qb are used. Signals I/Ib are not out of phase, i.e., they are in phase; hence, labels I and Ib are used.

[0022] Fig. 3A is a block diagram depicting quarter-rate phase detector 210 of Fig. 2 in more detail, according to an embodiment of the present invention. Quarter rate phase-detector 210 includes: error signal generation logic circuitry 318 that produces components of signal E , namely intermediate signals $e1-e4$; and reference signal generation logic circuitry 320 that produces components of signal R , namely signals $r1-r4$. Logic 320 overlaps logic 318 in the sense that both can be described as including a bank of four data latches 301-304. Logic 318 further includes: neighbor logic circuitry 322; and a 4:1 multiplexer 316. Logic 320 further includes: a second bank of data latches 305-308 cascade-connected to latches 301-304, respectively; and a MUX unit

324. Neighbor logic 322 includes XOR gates 309-311. MUX unit 324 includes 2:1 multiplexers 314 and 315.

[0023] In Figs. 3A and 3B, some simplifications have been made for the purpose of illustration. Those simplifications include the following. Each of data latches 301-304 receives signal D_{in} and its inverted counterpart, and each provides signals at their Q and Qb outputs, but only the labels for the signals at the Q outputs (namely, $m1$ - $m4$, respectively) are explicitly depicted. Data latches 305-308 provide signals at their Q and Qb outputs, but only the labels for signals at the Q outputs (namely, $r1$ - $r4$, respectively) are explicitly depicted. Multiplexers 314 and 315 output signals and their inverted counterparts, but only the non-inverted signals (namely, $rd1$ and $rd2$, respectively) are explicitly labeled. XOR gates 309-312 provide signals and their inverted counterparts, but only the non-inverted signals (namely, $e1$ - $e4$, respectively) are explicitly labeled. One of ordinary skill in the art will understand that the labels for the inverted counterparts, e.g., $\overline{e1}$ - $\overline{e4}$, etc. are implied.

[0024] Operation of error signal generation logic 318 is as follows. Signals D_{in} and $\overline{D_{in}}$ are provided at inputs D and Db to each of latches 301-304, while corresponding signals $m1$ - $m4$ and $\overline{m1}$ - $\overline{m4}$ (latched according to clock signals I , Q , Ib and Qb) are made available on outputs Q and Qb , respectively. Signals $m1$, $\overline{m1}$ are fed to inputs of XOR gates 309-310. In similar cyclic fashion, signals $m2$, $\overline{m2}$ are fed to inputs of XOR gates 310-311, and $m3$, $\overline{m3}$ are fed to inputs of XOR gates 310-311. In corresponding cyclic fashion, signals $m4$, $\overline{m4}$ are fed to an input of XOR gate 311 and to the other inputs of XOR gate 309.

[0025] The exhibition of non-zero phase difference in signals e_1 - e_4 at outputs of XOR gates 309-312 moves cyclically in a sequence e_1, e_2, e_3, e_4, e_1 , etc.; the same applies for signals $\overline{e_1}-\overline{e_4}$. Hence, Outputs e_1-e_4 and $\overline{e_1}-\overline{e_4}$ are fed to multiplexer 316, which selects a pair e_j and $\overline{e_j}$ according to signals I and Q. As multiplexer 316 is controlled to select a subsequent different pair e_{j+1} and $\overline{e_{j+1}}$, etc., the effect is to construct signals E and Eb as a serial sequence of cyclically repeated samples of signals e_j and $\overline{e_j}$, respectively. Whereas phase detector 102 according to the Background Art extracted the error signal directly from XOR gate 126, phase detector 210 (according to an embodiment of the present invention) indirectly extracts E and Eb by way of multiplexer 316 interposed between XOR gates 309-312 and outputs of phase detector 210.

[0026] Fig. 3B is a table depicting an example truth table for multiplexer 316 according to an embodiment of the present invention. For each combination of signals I and Q, the particular signal e_j selected by multiplexer 316 is shown. Fig. 3C depicts waveforms I and Q as they change to exhibit the combinations listed in Fig. 3B.

[0027] Fig. 3D is a block diagram depicting multiplexer 316 in more detail, according to an embodiment of the present invention. Multiplexer 316 includes: 2:1 multiplexers 330 and 332 can receive signals $e_1, \overline{e_1}, e_3, \overline{e_3}$ and $e_2, \overline{e_2}, e_4, \overline{e_4}$, respectively. Selections of multiplexers 330 and 332 can be controlled according to signal Q. Multiplexer 334 can receive, and selects from, the outputs of multiplexers 330 and 332 according to signal I to produce signals E and Eb.

[0028] Operation of reference signal generation logic 320 is as follows. Signals $m1-m4$ and $\overline{m1}-\overline{m4}$ are provided at inputs D and Db to each of latches 305-309, while corresponding signals $r1-r4$ and $\overline{r1}-\overline{r4}$ (latched according to clock signals Ib, Qb, I and Q) are made available on outputs Q and Qb, respectively. Multiplexer 314 can receive, and selects from, signals $r1, \overline{r1}$ and $r3, \overline{r3}$ according to signal I so as to produce signals $rd1, \overline{rd1}$. Multiplexer 315 can receive, and selects from, signals $r2, \overline{r2}$ and $r4, \overline{r4}$ according to signal Q so as to produce signals $rd2, \overline{rd2}$. Outputs $rd1, \overline{rd1}$ and outputs $rd2, \overline{rd2}$ can be fed to XOR gate 313, which produces signals R and Rb. As multiplexer 314 is controlled to select between signals $r1, \overline{r1}$ and $r3, \overline{r3}$, the effect is to construct signals $rd1, \overline{rd1}$ as serial sequences of alternating samples of signals $r1, \overline{r1}$ and $r3, \overline{r3}$; likewise for multiplexer 315.

[0029] For example, where a rate of D_{in} is 40 Gb/sec, then the corresponding rate of regenerated clock signals I, Ib, Q and Qb is 10 GHz. In other words, signals I, Ib, Q and Qb are $\frac{1}{4}$ of the rate of D_{in} . As phase detector 210 operates upon signals I, Ib, Q and Qb, it can be described as a quarter-rate phase detector. Extending the example, signals $e1-e4, \overline{e1}-\overline{e4}$ and $r1-r4, \overline{r1}-\overline{r4}$ would each have a rate of 10 Gb/sec or $\frac{1}{4}$ of the rate of D_{in} .

[0030] Operation of CDR circuit 200 is as follows. It is to be noted that signals $r1-r4, \overline{r1}-\overline{r4}$ represent re-timed data signals $D_A - D_D, \overline{D_C} - \overline{D_D}$, respectively. In other words, the retimed $\frac{1}{4}$ rate data signals are inherently generated at outputs of latches 305-308 as part of the generation of signals R and Rb.

[0031] Fig. 4 depicts waveforms for signals mentioned above in the example circumstance when the clock is locked. Error signals E, Eb have a signal width Θ_E that is half of the signal width Θ_R (relative to D_{in} , $\overline{D_{in}}$) of signals R, Rb. In this case, total phase error is taken as the difference between signal width Θ_R and twice the value of signal width Θ_E , namely $2\Theta_E$. Charge pump 220 discharges when $2\Theta_E$ is less than Θ_R and charges when $2\Theta_E$ is greater than Θ_R . When $2\Theta_E$ equals Θ_R , the clock is locked. Fig. 5 depicts waveforms for signals mentioned above in the example circumstance that error signals E, Eb lead D_{in} , $\overline{D_{in}}$, namely where $2\Theta_E < \Theta_R$. Fig. 6 depicts waveforms for signals mentioned above in the example circumstance that error signals E, Eb lag D_{in} , $\overline{D_{in}}$, namely where $2\Theta_E > \Theta_R$.

[0032] The present invention may be embodied in other forms without departing from its spirit and essential characteristics. The described embodiments are to be considered only non-limiting examples of the present invention. The scope of the present invention is to be measured by associated claims. All changes which come within the meaning and equivalency of the claims are to be embraced within their scope.

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